

FORM PTO-1449 (Modified)

LIST OF PATENTS AND PUBLICATIONS FOR  
APPLICANT'S INFORMATION DISCLOSURE  
STATEMENTATTY. DOCKET NO.  
KLR 7146.0117SERIAL NO.  
10/074,480

APPLICANT

Ishli

FILING DATE  
February 11, 2002GROUP  
2681

(Use several sheets if necessary)

## REFERENCE DESIGNATION

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
WK	AA	6,105,570	Feb. 27, 2001	Ishida	455	566	9/28/98
WK	AB	Publication Number: 2002/0016188 A1	Feb. 7, 2002	Kashiwamura	455	566	6/22/01
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## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE FILED	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
WK	BA	EP 1 154 621 A1	May 11, 2000	Europe	—	—		
	BB							

## OTHER ART

	CA	

Examiner Signature	<i>Worley Finn</i>	Date Considered	8/24/04
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<sup>1</sup> Unique citation designation number. <sup>2</sup> Applicant is to place a check mark here if English language translation is attached.Q:\Bonnie Dillon\KLR\SHARP\Patents\0117\1449 Disclosure Form.wpd;  
March 2, 2004 (1:36PM)



# INFORMATION DISCLOSURE STATEMENT BY APPLICANT

Sheet 1 of 1

## Complete If Known

Application Number 10/074480  
Filing Date 02/11/02  
First Named Inventor Ishii  
Art Unit  
Examiner Name  
Attorney's Docket No. TAL:7146.117

## U.S. PATENT DOCUMENTS

Examiner Initials	Cite No.	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines where passages or relevant figures appear
		Number - Kind Code (if known)			
WK	AA	US- 4975949	12-04-1990	Wimsatt et al.	
WK	AB	US- 5191602	03-02-1993	Regen et al.	
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	AT	US-			
	AU	US-			

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## FOREIGN PATENT DOCUMENTS

Examiner Initials	Cite No. <sup>1</sup>	Foreign Patent Documents	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, columns, lines where passages or relevant figures appear	T <sup>1</sup>
		Country Code - Number - Kind Code				
	BA					
	BB					
	BC					
	BD					
	BE					
	BF					
	BG					
	BH					
	BI					
	BJ					

Examiner Signature *Worley* Date Considered 3/24/04

Applicant is to place a check mark here if English language translation is attached.